Notes	Searcn

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/072,415	LEE ET AL.	
Examiner	Art Unit	
Steven J. Fulk	2891	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Updated EAST search	3/23/2007	SJF	
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